

BF992 Silicon N-channel dual gate MOS-FET Rev. 04 — 21 November 2007

Product data sheet

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NXP Semiconductors



APPLICATIONS

• VHF applications such as VHF television tuners and FM tuners with 12 V supply voltage. The device is also suitable for use in professional communications equipment.

DESCRIPTION

Depletion type field-effect transistor in a plastic micro-miniature SOT143B package with source and substrate interconnected.

The transistor is protected against excessive input voltage surges by integrated back-to-back diodes between gates and source.

CAUTION

The device is supplied in an antistatic package. The gate-source input must be protected against static discharge during transport or handling.

PINNING

PIN SYMBOL		DESCRIPTION
1	s, b	source
2	d	drain
3	g 2	gate 2
4	g ₁	gate 1

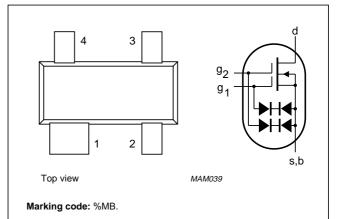


Fig.1 Simplified outline (SOT143B) and symbol.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V _{DS}	drain-source voltage (DC)		-	20	V
I _D	drain current (DC)		-	40	mA
P _{tot}	total power dissipation	T _{amb} = 60 °C	-	200	mW
Y _{fs}	forward transfer admittance	f = 1 kHz; I_D = 15 mA; V_{DS} = 10 V; V_{G2-S} = 4 V	25	-	mS
C _{ig1-s}	input capacitance at gate 1	f = 1 MHz; I_D = 15 mA; V_{DS} = 10 V; V_{G2-S} = 4 V	4	-	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz; I_D = 15 mA; V_{DS} = 10 V; V_{G2-S} = 4 V	30	-	fF
F	noise figure		1.2	-	dB
Tj	operating junction temperature		-	150	°C

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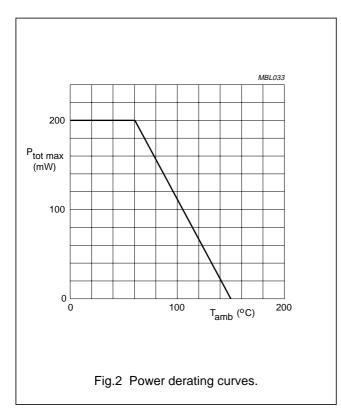
LIMITING VALUES

In accordance with the Absolute Maximum Rating System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{DS}	drain-source voltage		_	20	V
I _D	drain current		-	40	mA
I _{G1}	gate 1 current		-	±10	mA
I _{G2}	gate 2 current		-	±10	mA
P _{tot}	total power dissipation	$T_{amb} \le 60 \text{ °C}$; see Fig.2; note 1	-	200	mW
T _{stg}	storage temperature		-65	+150	°C
Tj	operating junction temperature		_	150	°C

Note

1. Device mounted on a ceramic substrate, 8 mm \times 10 mm \times 0.7 mm.



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THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R _{th j-a}	thermal resistance from junction to ambient in free air	note 1	460	K/W

Note

1. Device mounted on a ceramic substrate, 8 mm \times 10 mm \times 0.7 mm.

STATIC CHARACTERISTICS

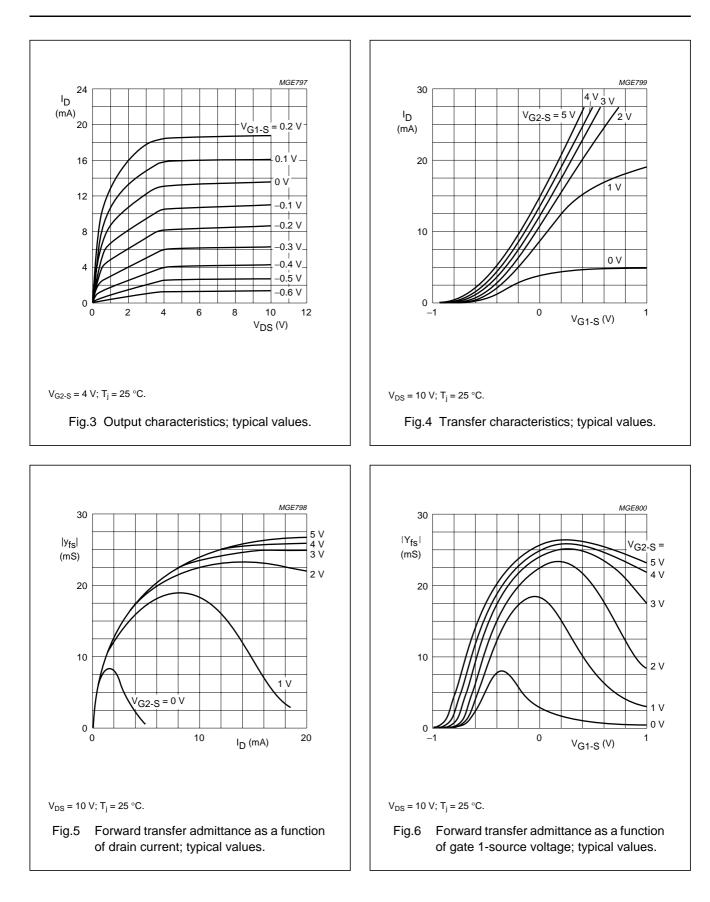
 $T_i = 25 \ ^{\circ}C$ unless otherwise specified.

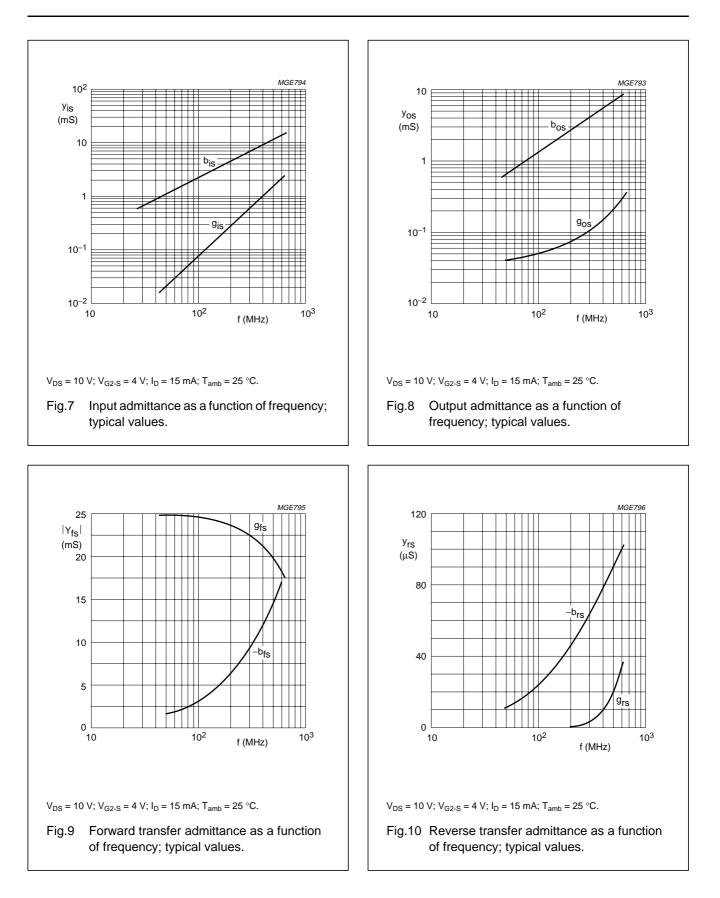
SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
±V _{(BR)G1-SS}	gate 1-source breakdown voltage	$V_{G2-S} = V_{DS} = 0; I_{G1-SS} = \pm 10 \text{ mA}$	8	20	V
±V _{(BR)G2-SS}	gate 2-source breakdown voltage	$V_{G1-S} = V_{DS} = 0$; $I_{G2-SS} = \pm 10 \text{ mA}$	8	20	V
-V _{(P)G1-S}	gate 1-source cut-off voltage	$V_{G2-S} = 4 \text{ V}; V_{DS} = 10 \text{ V}; I_D = 20 \ \mu\text{A}$	0.2	1.3	V
-V _{(P)G2-S}	gate 2-source cut-off voltage	$V_{G1-S} = 0; V_{DS} = 10 \text{ V}; I_D = 20 \mu\text{A}$	0.2	1.1	V
±I _{G1-SS}	gate 1 cut-off current	$V_{G2-S} = V_{DS} = 0; V_{G1-S} = \pm 7 V$	-	25	nA
±I _{G2-SS}	gate 2 cut-off current	$V_{G1-S} = V_{DS} = 0; V_{G2-S} = \pm 7 V$	-	25	nA

DYNAMIC CHARACTERISTICS

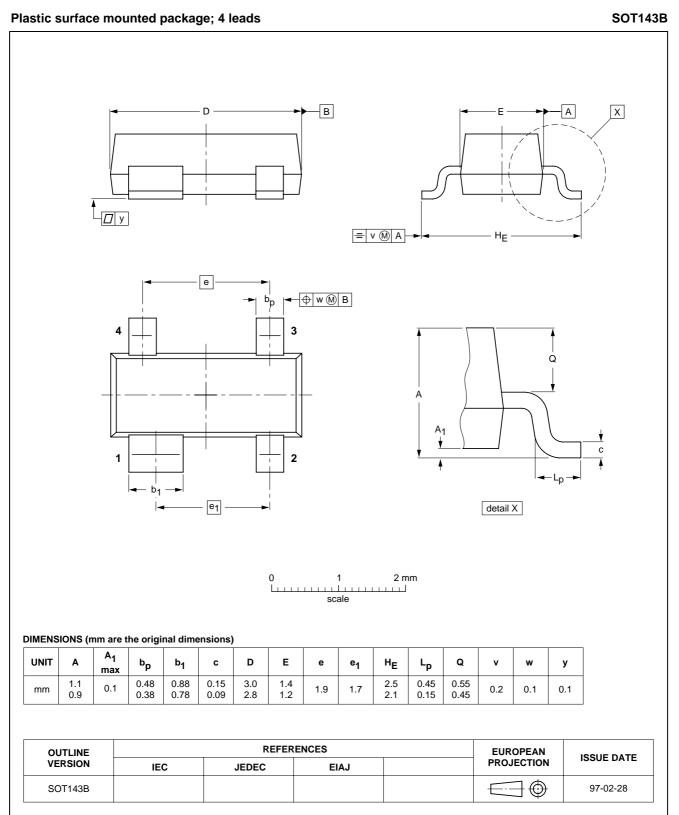
Common source; T_{amb} = 25 °C; V_{DS} = 10 V; V_{G2-S} = 4 V; I_D = 15 mA; unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
y _{fs}	forward transfer admittance		20	25	-	mS
C _{ig1-s}	input capacitance at gate 1	f = 1 MHz	-	4	-	pF
C _{ig2-s}	input capacitance at gate 2	f = 1 MHz	-	1.7	-	pF
C _{os}	output capacitance	f = 1 MHz	-	2	-	pF
C _{rs}	reverse transfer capacitance	f = 1 MHz	_	30	40	fF
F	noise figure	f = 200 MHz; G _S = 2 mS	_	1.2	_	dB





PACKAGE OUTLINE



Legal information

Data sheet status

Document status ^{[1][2]}	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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Revision history

Revision history				
Document ID	Release date	Data sheet status	Change notice	Supersedes
BF992_N_4	20071121	Product data sheet	-	BF992_3
Modifications:	 Fig. 1 on pa 	ige 2; Figure note changed		
BF992_3 (9397 750 06013)	19990811	Product specification	-	BF992_2
BF992_2	19960730	Product specification	-	BF992_SF_1
BF992_SF_1	-	-	-	-

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